# 256K x 36/512K x 18 Pipelined SRAM

#### **Features**

- Fast access times: 2.5 ns, 3.0 ns, and 3.5 ns
- Fast clock speed: 225, 200, 166, and 150 MHz
- Fast OE access times: 2.5 ns, 3.0 ns, and 3.5 ns
- Optimal for depth expansion (one cycle chip deselect to eliminate bus contention)
- 3.3V -5% and +10% power supply
- 3.3V or 2.5V I/O supply
- 5V tolerant inputs except I/Os
- Clamp diodes to V<sub>SS</sub> at all inputs and outputs
- Common data inputs and data outputs
- . Byte Write Enable and Global Write control
- Multiple chip enables for depth expansion: three chip enables for TA package version and two chip enables for B and T package versions
- Address pipeline capability
- · Address, data, and control registers
- Internally self-timed Write Cycle
- Burst control pins (interleaved or linear burst sequence)
- Automatic power-down for portable applications
- JTAG boundary scan for B and T package version
- Low profile 119-bump, 14-mm x 22-mm PBGA (Ball Grid Array) and 100-pin TQFP packages

### **Functional Description**

The Cypress Synchronous Burst SRAM family employs high-speed, low-power CMOS designs using advanced triple-layer polysilicon, double-layer metal technology. Each memory cell consists of four transistors and two high-valued resistors.

The CY7C1360A/GVT71256D36 and CY7C1362A/GVT71512D18 SRAMs integrate 262,144x36 and 524,288x18 SRAM cells with advanced synchronous peripheral circuitry

and a 2-bit counter for internal burst operation. All synchronous inputs are gated by registers controlled by a positive-edge-triggered Clock Input (CLK). The synchronous inputs include all addresses, all data inputs, address-pipelining Chip Enable ( $\overline{\text{CE}}$ ), depth-expansion Chip Enables ( $\overline{\text{CE}}_2$  and  $\overline{\text{CE}}_2$ ), burst control inputs ( $\overline{\text{ADSC}}$ ,  $\overline{\text{ADSP}}$ , and  $\overline{\text{ADV}}$ ), Write Enables ( $\overline{\text{BWa}}$ ,  $\overline{\text{BWb}}$ ,  $\overline{\text{BWc}}$ ,  $\overline{\text{BWd}}$ , and  $\overline{\text{BWE}}$ ), and global write ( $\overline{\text{GW}}$ ). However, the  $\overline{\text{CE}}_2$  chip enable input is only available for the TA package version.

Asynchronous inputs include the Output Enable  $(\overline{OE})$  and burst mode control (MODE). The data outputs (Q), enabled by  $\overline{OE}$ , are also asynchronous.

Addresses and chip enables are registered with either Address Status Processor (ADSP) or Address Status Controller (ADSC) input pins. Subsequent burst addresses can be internally generated as controlled by the Burst Advance Pin (ADV).

Address, data inputs, and write controls are registered on-chip to initiate self-timed WRITE cycle. WRITE cycles can be one to four bytes wide as controlled by the write control inputs. Individual byte write allows individual byte to be written. BWa controls DQa. BWb controls DQb. BWc controls DQc. BWd controls DQd. BWa, BWb, BWc, and BWd can be active only with BWE being LOW. GW being LOW causes all bytes to be written. The x18 version only has 18 data inputs/outputs (DQa and DQb) along with BWa and BWb (no BWc, BWd, DQc, and DQd).

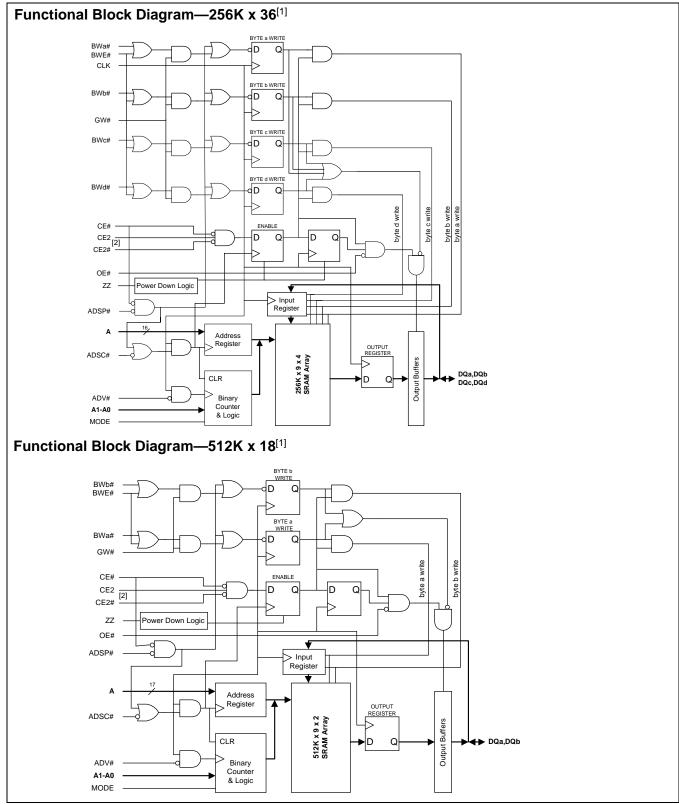
For the B and T package versions, four pins are used to implement JTAG test capabilities: Test Mode Select (TMS), Test Data-In (TDI), Test Clock (TCK), and Test Data-Out (TDO). The JTAG circuitry is used to serially shift data to and from the device. JTAG inputs use LVTTL/LVCMOS levels to shift data during this testing mode of operation. The TA package version does not offer the JTAG capability.

The CY7C1360A/GVT71256D36 and CY7C1362A/GVT71512D18 operate from a +3.3V power supply. All inputs and outputs are LVTTL compatible.

### **Selection Guide**

		7C1360A-225 71256D36-4.4 7C1362A-225 71512D18-4.4	7C1360A-200 71256D36-5 7C1362A-200 71512D18-5	7C1360A-166 71256D36-6 7C1362A-166 71512D18-6	7C1360A-150 71256D36-6.7 7C1362A-150 71512D18-6.7
Maximum Access Time (ns)		2.5	3.0	3.5	3.5
Maximum Operating Current (mA) Commercial		570	510	425	380
Maximum CMOS Standby Current (mA)		10	10	10	10



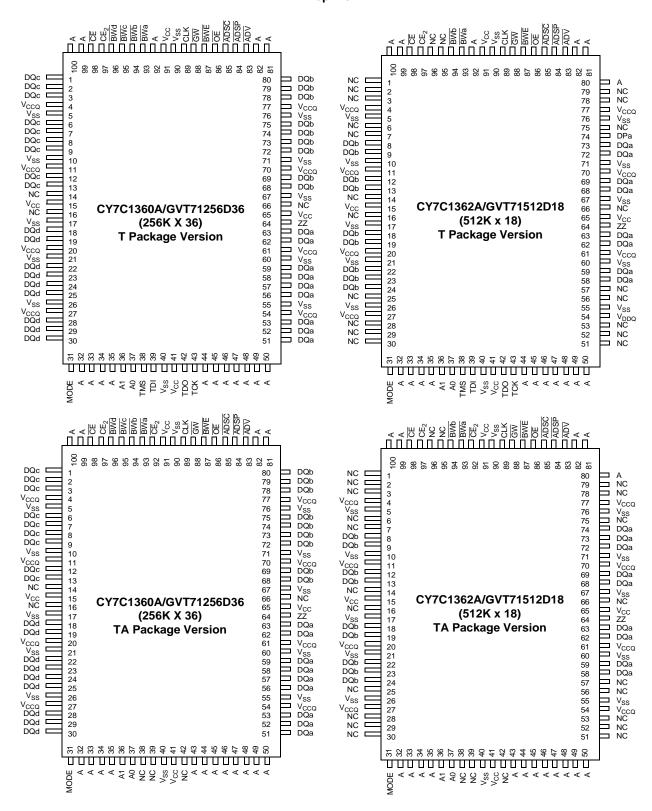


### Notes:



### **Pin Configurations**

#### 100-Pin TQFP Top View





# Pin Configurations (continued)

### 119-Ball BGA Top View

### 256Kx36

	1	2	3	4	5	6	7
Α	V <sub>CCQ</sub>	Α	А	ADSP	Α	А	V <sub>CCQ</sub>
В	NC	CE <sub>2</sub>	Α	ADSC	Α	Α	NC
С	NC	Α	Α	V <sub>CC</sub>	Α	Α	NC
D	DQc	DQc	$V_{SS}$	NC	$V_{SS}$	DQb	DQb
Е	DQc	DQc	V <sub>SS</sub>	CE	V <sub>SS</sub>	DQb	DQb
F	V <sub>CCQ</sub>	DQc	$V_{SS}$	ŌĒ	$V_{SS}$	DQb	V <sub>CCQ</sub>
G	DQc	DQc	BWc	ADV	BWb	DQb	DQb
Н	DQc	DQc	$V_{SS}$	GW	$V_{SS}$	DQb	DQb
J	V <sub>CCQ</sub>	V <sub>CC</sub>	NC	V <sub>CC</sub>	NC	V <sub>CC</sub>	V <sub>CCQ</sub>
K	DQd	DQd	$V_{SS}$	CLK	$V_{SS}$	DQa	DQa
L	DQd	DQd	BWd	NC	BWa	DQa	DQa
M	V <sub>CCQ</sub>	DQd	$V_{SS}$	BWE	$V_{SS}$	DQa	V <sub>CCQ</sub>
N	DQd	DQd	$V_{SS}$	A1	$V_{SS}$	DQa	DQa
Р	DQd	DQd	$V_{SS}$	A0	$V_{SS}$	DQa	DQa
R	NC	Α	MODE	V <sub>CC</sub>	NC	Α	NC
Т	NC	NC	Α	Α	Α	NC	ZZ
U	V <sub>CCQ</sub>	TMS	TDI	TCK	TDO	NC	V <sub>CCQ</sub>

### 512Kx18

	1	2	3	4	5	6	7
Α	V <sub>CCQ</sub>	Α	А	ADSP	Α	Α	V <sub>CCQ</sub>
В	NC	CE <sub>2</sub>	А	ADSC	Α	CE2	NC
С	NC	Α	А	V <sub>CC</sub>	Α	Α	NC
D	DQb	NC	V <sub>SS</sub>	NC	$V_{SS}$	DQa	NC
E	NC	DQb	V <sub>SS</sub>	CE	$V_{SS}$	NC	DQa
F	V <sub>CCQ</sub>	NC	$V_{SS}$	ŌĒ	$V_{SS}$	DQa	V <sub>CCQ</sub>
G	NC	DQb	BWb	ADV	$V_{SS}$	NC	DQa
Н	DQb	NC	$V_{SS}$	GW	$V_{SS}$	DQa	NC
J	V <sub>CCQ</sub>	$V_{CC}$	NC	V <sub>CC</sub>	NC	$V_{CC}$	V <sub>CCQ</sub>
K	NC	DQb	$V_{SS}$	CLK	$V_{SS}$	NC	DQa
L	DQb	NC	$V_{SS}$	NC	BWa	DQa	NC
М	V <sub>CCQ</sub>	DQb	$V_{SS}$	BWE	$V_{SS}$	NC	V <sub>CCQ</sub>
N	DQb	NC	$V_{SS}$	A1	$V_{SS}$	DQa	NC
Р	NC	DQb	$V_{SS}$	A0	$V_{SS}$	NC	DQa
R	NC	Α	MODE	V <sub>CC</sub>	NC	Α	NC
Т	NC	Α	Α	NC	Α	Α	ZZ
U	V <sub>CCQ</sub>	TMS	TDI	TCK	TDO	NC	$V_{CCQ}$



# 256K X 36 Pin Descriptions

X36 PBGA Pins	X36 QFP Pins	Name	Туре	Description
4P 4N 2A, 3A, 5A, 6A, 3B, 5B, 6B, 2C, 3C, 5C, 6C, 2R, 6R, 3T, 4T, 5T	37 36 35, 34, 33, 32, 100, 99, 82, 81, 44, 45, 46, 47, 48, 49, 50 92 (T Version) 43 (TA Version)	A0 A1 A	Input- Synchronous	Addresses: These inputs are registered and must meet the set-up and hold times around the rising edge of CLK. The burst counter generates internal addresses associated with A0 and A1, during burst cycle and wait cycle.
5L 5G 3G 3L	93 94 95 96	BWa BWb BWc BWd	Input- Synchronous	Byte Write: A byte write is LOW for a WRITE cycle and HIGH for a READ cycle. BWa controls DQa. BWb controls DQb. BWc controls DQc. BWd controls DQd. Data I/O are high impedance if either of these inputs are LOW, conditioned by BWE being LOW.
4M	87	BWE	Input- Synchronous	Write Enable: This active LOW input gates byte write operations and must meet the set-up and hold times around the rising edge of CLK.
4H	88	GW	Input- Synchronous	Global Write: This active LOW input allows a full 36-bit WRITE to occur independent of the BWE and BWn lines and must meet the set-up and hold times around the rising edge of CLK.
4K	89	CLK	Input- Synchronous	Clock: This signal registers the addresses, data, chip enables, write control, and burst control inputs on its rising edge. All synchronous inputs must meet set-up and hold times around the clock's rising edge.
4E	98	CE	Input- Synchronous	Chip Enable: This active LOW input is used to enable the device and to gate ADSP.
2B	97	CE <sub>2</sub>	Input- Synchronous	Chip Enable: This active HIGH input is used to enable the device.
- (not available for PBGA)	92 (for TA Version only)	CE <sub>2</sub>	Input- Synchronous	Chip Enable: This active LOW input is used to enable the device. Not available for B and T package versions.
4F	86	ŌĒ	Input	Output Enable: This active LOW asynchronous input enables the data output drivers.
4G	83	ADV	Input- Synchronous	Address Advance: This active LOW input is used to control the internal burst counter. A HIGH on this pin generates wait cycle (no address advance).
4A	84	ADSP	Input- Synchronous	Address Status Processor: This active LOW input, along with $\overline{CE}$ being LOW, causes a new external address to be registered and a READ cycle is initiated using the new address.
4B	85	ADSC	Input- Synchronous	Address Status Controller: This active LOW input causes the device to be deselected or selected along with new external address to be registered. A READ or WRITE cycle is initiated depending upon write control inputs.
3R	31	MODE	Input- Static	Mode: This input selects the burst sequence. A LOW on this pin selects Linear Burst. A NC or HIGH on this pin selects Interleaved Burst.
7T	64	ZZ	Input- Asynchronous	Snooze: This active HIGH input puts the device in low power consumption standby mode. For normal operation, this input has to be either LOW or NC (No Connect).



# 256K X 36 Pin Descriptions (continued)

X36 PBGA Pins	X36 QFP Pins	Name	Туре	Description
(a) 6P, 7P, 7N, 6N, 6M, 6L, 7L, 6K, 7K, (b) 7H, 6H, 7G, 6G, 6F, 6E, 7E, 7D, 6D, (c) 2D, 1D, 1E, 2E, 2F, 1G, 2G, 1H, 2H, (d) 1K, 2K, 1L, 2L, 2M, 1N, 2N, 1P, 2P	(a) 51, 52, 53, 56, 57, 58, 59, 62, 63 (b) 68, 69, 72, 73, 74, 75, 78, 79, 80 (c) 1, 2, 3, 6, 7, 8, 9, 12, 13 (d) 18, 19, 22, 23, 24, 25, 28, 29, 30	DQa DQb DQc DQd	Input/ Output	Data Inputs/Outputs: First Byte is DQa. Second Byte is DQb. Third Byte is DQc. Fourth Byte is DQd. Input data must meet set-up and hold times around the rising edge of CLK.
2U 3U 4U	38 39 43 for B and T version	TMS TDI TCK	Input	IEEE 1149.1 test inputs. LVTTL-level inputs. Not available for TA package version.
5U	42 for B and T version	TDO	Output	IEEE 1149.1 test output. LVTTL-level output. Not available for TA package version.
4C, 2J, 4J, 6J, 4R	15, 41, 65, 91	V <sub>CC</sub>	Supply	Core power Supply: +3.3V –5% and +10%
3D, 5D, 3E, 5E, 3F, 5F, 3H, 5H, 3K, 5K, 3M, 5M, 3N, 5N, 3P, 5P	5, 10, 17, 21, 26, 40, 55, 60, 67, 71, 76, 90	V <sub>SS</sub>	Ground	Ground: GND.
1A, 7A, 1F, 7F, 1J, 7J, 1M, 7M, 1U, 7U	4, 11, 20, 27, 54, 61, 70, 77	V <sub>CCQ</sub>	I/O Supply	Output Buffer Supply: +2.5V or +3.3V.
1B, 7B, 1C, 7C, 4D, 3J, 5J, 4L, 1R, 5R, 7R, 1T, 2T, 6T, 6U	14, 16, 66 38, 39, 42 for TA Version	NC	-	No Connect: These signals are not internally connected. User can leave it floating or connect it to $V_{CC}$ or $V_{SS}$ .

# 512K X 18 Pin Descriptions

X18 PBGA Pins	X18 QFP Pins	Name	Туре	Description
4P 4N 2A, 3A, 5A, 6A, 3B, 5B, 6B, 2C, 3C, 5C, 6C, 2R, 6R, 2T, 3T, 5T, 6T	37 36 35, 34, 33, 32, 100, 99, 82, 81, 80, 48, 47, 46, 45, 44, 49, 50 92 (T Version) 43 (TA Version)	A0 A1 A	Input- Synchronous	Addresses: These inputs are registered and must meet the set up and hold times around the rising edge of CLK. The burst counter generates internal addresses associated with A0 and A1, during burst cycle and wait cycle.
5L 3G	93 94	BWa BWb	Input- Synchronous	Byte Write Enables: A byte write enable is <u>LOW</u> for a WRIT <u>E</u> cycle and HIGH for a READ cycle. BWa controls DQa. BWb controls DQb. Data I/O are high impedance if either of these inputs are LOW, conditioned by BWE being LOW.
4M	87	BWE	Input- Synchronous	Write Enable: This active LOW input gates byte write operations and must meet the set-up and hold times around the rising edge of CLK.
4H	88	GW	Input- Synchronous	Global Write: This active LOW input allows a full 18-bit WRITE to occur independent of the BWE and WEn lines and must meet the set-up and hold times around the rising edge of CLK.
4K	89	CLK	Input- Synchronous	Clock: This signal registers the addresses, data, chip enables, write control and burst control inputs on its rising edge. All synchronous inputs must meet set-up and hold times around the clock's rising edge.
4E	98	CE	Input- Synchronous	Chip Enable: This active LOW input is used to enable the device and to gate ADSP.



# 512K X 18 Pin Descriptions (continued)

X18 PBGA Pins	X18 QFP Pins	Name	Туре	Description
2B	97	CE2	Input- Synchronous	Chip Enable: This active HIGH input is used to enable the device.
- (not available for PBGA)	92 (for TA Version only)	CE2	Input- Synchronous	Chip Enable: This active LOW input is used to enable the device. Not available for B and T package versions.
4F	86	ŌĒ	Input	Output Enable: This active LOW asynchronous input enables the data output drivers.
4G	83	ADV	Input- Synchronous	Address Advance: This active LOW input is used to control the internal burst counter. A HIGH on this pin generates wait cycle (no address advance).
4A	84	ADSP	Input- Synchronous	Address Status Processor: This active LOW input, along with $\overline{\text{CE}}$ being LOW, causes a new external address to be registered and a READ cycle is initiated using the new address.
4B	85	ADSC	Input- Synchronous	Address Status Controller: This active LOW input causes device to be deselected or selected along with new external address to be registered. A READ or WRITE cycle is initiated depending upon write control inputs.
3R	31	MODE	Input- Static	Mode: This input selects the burst sequence. A LOW on this pin selects Linear Burst. An NC or HIGH on this pin selects Interleaved Burst.
7T	64	ZZ	Input- Asynchronous	Snooze: This active HIGH input puts the device in low power consumption standby mode. For normal operation, this input has to be either LOW or NC (No Connect).
(a) 6D, 7E, 6F, 7G, 6H, 7K, 6L, 6N, 7P (b) 1D, 2E, 2G, 1H, 2K, 1L, 2M, 1N, 2P	(a) 58, 59, 62, 63, 68, 69, 72, 73, 74 (b) 8, 9, 12, 13, 18, 19, 22, 23, 24	DQa DQb	Input/ Output	Data Inputs/Outputs: Low Byte is DQa. High Byte is DQb. Input data must meet set up and hold times around the rising edge of CLK.
2U 3U 4U	38 39 43 for B and T version	TMS TDI TCK	Input	IEEE 1149.1 test inputs. LVTTL-level inputs. Not available for TA package version.
5U	42 for B and T version	TDO	Output	IEEE 1149.1 test output. LVTTL-level output. Not available for TA package version.
4C, 2J, 4J, 6J, 4R	15, 41,65, 91	V <sub>CC</sub>	Supply	Core power Supply: +3.3V –5% and +10%
3D, 5D, 3E, 5E, 3F, 5F, 5G, 3H, 5H, 3K, 5K, 3L, 3M, 5M, 3N, 5N, 3P, 5P	5, 10, 17, 21, 26, 40, 55, 60, 67, 71, 76, 90	V <sub>SS</sub>	Ground	Ground: GND.
1A, 7A, 1F, 7F, 1J, 7J, 1M, 7M, 1U, 7U	4, 11, 20, 27, 54, 61, 70, 77	V <sub>CCQ</sub>	I/O Supply	Output Buffer Supply: +2.5V or +3.3V.
1B, 7B, 1C, 7C, 2D, 4D, 7D, 1E, 6E, 2F, 1G, 6G, 2H, 7H, 3J, 5J, 1K, 6K, 2L, 4L, 7L, 6M, 2N, 7N, 1P, 6P, 1R, 5R, 7R, 1T, 4T, 6U	1–3, 6, 7, 14, 16, 25, 28–30, 51–53, 56, 57, 66, 75, 78, 79, 80, 95, 96 38, 39, 42 for TA Version	NC	<u>-</u>	No Connect: These signals are not internally connected. User can leave it floating or connect it to $V_{CC}$ or $V_{SS}$ .



## Burst Address Table (MODE = $NC/V_{CC}$ )

First Address (external)	Second Address (internal)	Third Address (internal)	Fourth Address (internal)
AA00	AA01	AA10	AA11
AA01	AA00	AA11	AA10
AA10	AA11	AA00	AA01
AA11	AA10	AA01	AA00

### **Burst Address Table (MODE = GND)**

First Address (external)	Second Address (internal)	Third Address (internal)	Fourth Address (internal)
AA00	AA01	AA10	AA11
AA01	AA10	AA11	AA00
AA10	AA11	AA00	AA01
AA11	AA00	AA01	AA10

# **Truth Table**<sup>[3, 4, 5, 6, 7, 8, 9]</sup>

Operation	Address Used	CE	CE2	CE2	ADSP	ADSC	ADV	WRITE	OE	CLK	DQ
Deselected Cycle, Power Down	None	Н	Х	Χ	Χ	L	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power Down	None	L	Х	L	L	Х	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power Down	None	L	Н	Χ	L	Х	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power Down	None	L	Х	L	Н	L	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power Down	None	L	Н	Х	Н	L	Х	Х	Х	L-H	High-Z
READ Cycle, Begin Burst	External	L	L	Н	L	Х	Х	Х	L	L-H	Q
READ Cycle, Begin Burst	External	L	L	Н	L	Х	Х	Х	Н	L-H	High-Z
WRITE Cycle, Begin Burst	External	L	L	Н	Н	L	Х	L	Х	L-H	D
READ Cycle, Begin Burst	External	L	L	Н	Н	L	Х	Н	L	L-H	Q
READ Cycle, Begin Burst	External	L	L	Н	Н	L	Х	Н	Н	L-H	High-Z
READ Cycle, Continue Burst	Next	Х	Χ	Χ	Η	Н	L	Н	L	L-H	Q
READ Cycle, Continue Burst	Next	Х	Х	Χ	Н	Н	L	Н	Н	L-H	High-Z
READ Cycle, Continue Burst	Next	Н	Х	Χ	X	Н	L	Н	L	L-H	Q
READ Cycle, Continue Burst	Next	Н	Х	Х	Х	Н	L	Н	Н	L-H	High-Z
WRITE Cycle, Continue Burst	Next	Χ	Х	Χ	Н	Н	L	L	Х	L-H	D
WRITE Cycle, Continue Burst	Next	Н	Х	Х	X	Н	L	L	Х	L-H	D
READ Cycle, Suspend Burst	Current	Х	Х	Х	Н	Н	Н	Н	L	L-H	Q
READ Cycle, Suspend Burst	Current	Х	Х	Х	Н	Н	Н	Н	Н	L-H	High-Z
READ Cycle, Suspend Burst	Current	Н	Х	Х	Х	Н	Н	Н	L	L-H	Q
READ Cycle, Suspend Burst	Current	Н	Х	Χ	Χ	Н	Н	Н	Н	L-H	High-Z
WRITE Cycle, Suspend Burst	Current	Х	Х	Х	Н	Н	Н	L	Х	L-H	D
WRITE Cycle, Suspend Burst	Current	Н	Х	Х	Х	Н	Н	L	Х	L-H	D

### Notes:

X = "Don't Care." H = logic HIGH. L = logic LOW.

Tor X36 product, WRITE = L means [BWE + BWa\*BWb\*BWc\*BWd]\*GW equals LOW. WRITE = H means [BWE + BWa\*BWb\*BWc\*BWd]\*GW equals HIGH.

For X18 product, WRITE = L means [BWE + BWa\*BWb]\*GW equals LOW. WRITE = H means [BWE + BWa\*BWb]\*GW equals HIGH.

BWa enables write to DQa. BWb enables write to DQb. BWc enables write to DQc. BWd enables write to DQd.

All inputs except OE must meet set up and hold times around the rising edge (LOW to HIGH) of CLK.

Suspending burst generates wait cycle.!

For a write operation following a read operation, OE must be HIGH before the input data required set-up time plus High-Z time for OE and staying HIGH throughout

This device contains circuitry that will ensure the outputs will be in High-Z during power-up.

ADSP LOW along with chip being selected always initiates a READ cycle at the L-H edge of CLK. A WRITE cycle can be performed by setting WRITE LOW for the CLK L-H edge of the subsequent wait cycle. Refer to WRITE timing diagram for clarification.



### Partial Truth Table for READ/WRITE[10]

Function	GW	BWE	BWa	BWb	BWc	BWd
READ	Н	Н	X	X	X	Х
READ	Н	L	Н	Н	Н	Н
WRITE one byte	Н	L	L	Н	Н	Н
WRITE all bytes	Н	L	L	L	L	L
WRITE all bytes	L	Х	X	Х	Х	Х

### **IEEE 1149.1 Serial Boundary Scan (JTAG)**

#### Overview

This device incorporates a serial boundary scan access port (TAP). This port is designed to operate in a manner consistent with IEEE Standard 1149.1-1990 (commonly referred to as JTAG), but does not implement all of the functions required for IEEE 1149.1 compliance. Certain functions have been modified or eliminated because their implementation places extra delays in the critical speed path of the device. Nevertheless, the device supports the standard TAP controller architecture (the TAP controller is the state machine that controls the TAPs operation) and can be expected to function in a manner that does not conflict with the operation of devices with IEEE Standard 1149.1 compliant TAPs. The TAP operates using LVTTL/LVCMOS logic level signaling.

### **Disabling the JTAG Feature**

It is possible to use this device without using the JTAG feature. To disable the TAP controller without interfering with normal operation of the device, TCK should be tied LOW ( $V_{SS}$ ) to prevent clocking the device. TDI and TMS are internally pulled up and may be unconnected. They may alternately be pulled up to  $V_{CC}$  through a resistor. TDO should be left unconnected. Upon power-up the device will come up in a reset state which will not interfere with the operation of the device.

### **Test Access Port (TAP)**

#### **TCK - Test Clock (INPUT)**

Clocks all TAP events. All inputs are captured on the rising edge of TCK and all outputs propagate from the falling edge of TCK.

#### TMS - Test Mode Select (INPUT)

The TMS input is sampled on the rising edge of TCK. This is the command input for the TAP controller state machine. It is allowable to leave this pin unconnected if the TAP is not used. The pin is pulled up internally, resulting in a logic HIGH level.

#### TDI - Test Data In (INPUT)

The TDI input is sampled on the rising edge of TCK. This is the input side of the serial registers placed between TDI and TDO. The register placed between TDI and TDO is determined by the state of the TAP controller state machine and the instruction that is currently loaded in the TAP instruction register (refer to Figure 1, TAP Controller State Diagram). It is allowable to leave this pin unconnected if it is not used in an application. The pin is pulled up internally, resulting in a logic HIGH level. TDI is connected to the Most Significant Bit (MSB) of any register. (See Figure 2.)

#### Note:

10. For the X18 product, there are only BWa and BWb.

#### TDO - Test Data Out (OUTPUT)

The TDO output pin is used to serially clock data-out from the registers. The output that is active depending on the state of the TAP state machine (refer to *Figure 1*, TAP Controller State Diagram). Output changes in response to the falling edge of TCK. This is the output side of the serial registers placed between TDI and TDO. TDO is connected to the Least Significant Bit (LSB) of any register. (See *Figure 2*.)

#### **Performing a TAP Reset**

The TAP circuitry does not have a reset pin ( $\overline{TRST}$ , which is optional in the IEEE 1149.1 specification). A RESET can be performed for the TAP controller by forcing TMS HIGH ( $V_{CC}$ ) for five rising edges of TCK and pre-loads the instruction register with the IDCODE command. This type of reset does not affect the operation of the system logic. The reset affects test logic only.

At power-up, the TAP is reset internally to ensure that TDO is in a High-Z state.

### **Test Access Port (TAP) Registers**

#### Overview

The various TAP registers are selected (one at a time) via the sequences of ones and zeros input to the TMS pin as the TCK is strobed. Each of the TAPs registers are serial shift registers that capture serial input data on the rising edge of TCK and push serial data out on subsequent falling edge of TCK. When a register is selected, it is connected between the TDI and TDO pins.

#### Instruction Register

The instruction register holds the instructions that are executed by the TAP controller when it is moved into the run test/idle or the various data register states. The instructions are three bits long. The register can be loaded when it is placed between the TDI and TDO pins. The parallel outputs of the instruction register are automatically preloaded with the IDCODE instruction upon power-up or whenever the controller is placed in the test-logic reset state. When the TAP controller is in the Capture-IR state, the two least significant bits of the serial instruction register are loaded with a binary "01" pattern to allow for fault isolation of the board-level serial test data path.

### **Bypass Register**

The bypass register is a single-bit register that can be placed between TDI and TDO. It allows serial test data to be passed through the device TAP to another device in the scan chain with minimum delay. The bypass register is set LOW ( $V_{SS}$ ) when the BYPASS instruction is executed.



#### **Boundary Scan Register**

The Boundary Scan register is connected to all the input and bidirectional I/O pins (not counting the TAP pins) on the device. This also includes a number of NC pins that are reserved for future needs. There are a total of 70 bits for the x36 device and 51 bits for the x18 device. The boundary scan register, under the control of the TAP controller, is loaded with the contents of the device I/O ring when the controller is in Capture-DR state and then is placed between the TDI and TDO pins when the controller is moved to Shift-DR state. The EXTEST, SAM-PLE/PRELOAD and SAMPLE-Z instructions can be used to capture the contents of the I/O ring.

The Boundary Scan Order table describes the order in which the bits are connected. The first column defines the bit's position in the boundary scan register. The MSB of the register is connected to TDI, and LSB is connected to TDO. The second column is the signal name, the third column is the TQFP pin number, and the fourth column is the BGA bump number.

### Identification (ID) Register

The ID Register is a 32-bit register that is loaded with a device and vendor specific 32-bit code when the controller is put in Capture-DR state with the IDCODE command loaded in the instruction register. The register is then placed between the TDI and TDO pins when the controller is moved into Shift-DR state. Bit 0 in the register is the LSB and the first to reach TDO when shifting begins. The code is loaded from a 32-bit on-chip ROM. It describes various attributes of the device as described in the Identification Register Definitions table.

### **TAP Controller Instruction Set**

#### Overview

There are two classes of instructions defined in the IEEE Standard 1149.1-1990; the standard (public) instructions and device specific (private) instructions. Some public instructions are mandatory for IEEE 1149.1 compliance. Optional public instructions must be implemented in prescribed ways.

Although the TAP controller in this device follows the IEEE 1149.1 conventions, it is not IEEE 1149.1 compliant because some of the mandatory instructions are not fully implemented. The TAP on this device may be used to monitor all input and I/O pads, but can not be used to load address, data, or control signals into the device or to preload the I/O buffers. In other words, the device will not perform IEEE 1149.1 EXTEST, INTEST, or the preload portion of the SAMPLE/PRELOAD command.

When the TAP controller is placed in Capture-IR state, the two least significant bits of the instruction register are loaded with 01. When the controller is moved to the Shift-IR state the instruction is serially loaded through the TDI input (while the previous contents are shifted out at TDO). For all instructions, the TAP executes newly loaded instructions only when the controller is moved to Update-IR state. The TAP instruction sets for this device are listed in the following tables.

#### **EXTEST**

EXTEST is an IEEE 1149.1 mandatory public instruction. It is to be executed whenever the instruction register is loaded with all 0s. EXTEST is not implemented in this device.

The TAP controller does recognize an all-0 instruction. When an EXTEST instruction is loaded into the instruction register, the device responds as if a SAMPLE/PRELOAD instruction has been loaded. There is one difference between two instructions. Unlike SAMPLE/PRELOAD instruction, EXTEST places the device outputs in a High-Z state.

#### **IDCODE**

The IDCODE instruction causes a vendor-specific, 32-bit code to be loaded into the ID register when the controller is in Capture-DR mode and places the ID register between the TDI and TDO pins in Shift-DR mode. The IDCODE instruction is the default instruction loaded in the instruction upon power-up and at any time the TAP controller is placed in the test-logic reset state.

#### **SAMPLE-Z**

If the High-Z instruction is loaded in the instruction register, all output pins are forced to a High-Z state and the boundary scan register is connected between TDI and TDO pins when the TAP controller is in a Shift-DR state.

#### SAMPLE/PRELOAD

SAMPLE/PRELOAD is an IEEE 1149.1 mandatory instruction. The PRELOAD portion of the command is not implemented in this device, so the device TAP controller is not fully IEEE 1149.1-compliant.

When the SAMPLE/PRELOAD instruction is loaded in the instruction register and the TAP controller is in the Capture-DR state, a snap shot of the data in the device's input and I/O buffers is loaded into the boundary scan register. Because the device system clock(s) are independent from the TAP clock (TCK), it is possible for the TAP to attempt to capture the input and I/O ring contents while the buffers are in transition (i.e., in a metastable state). Although allowing the TAP to sample metastable inputs will not harm the device, repeatable results can not be expected. To guarantee that the boundary scan register will capture the correct value of a signal, the device input signals must be stabilized long enough to meet the TAP controller's capture set up plus hold time ( $t_{CS}$  plus  $t_{CH}$ ). The device clock input(s) need not be paused for any other TAP operation except capturing the input and I/O ring contents into the boundary scan register.

Moving the controller to Shift-DR state then places the boundary scan register between the TDI and TDO pins. Because the PRELOAD portion of the command is not implemented in this device, moving the controller to the Update-DR state with the SAMPLE/PRELOAD instruction loaded in the instruction register has the same effect as the Pause-DR command.

#### **BYPASS**

When the BYPASS instruction is loaded in the instruction register and the TAP controller is in the Shift-DR state, the bypass register is placed between TDI and TDO. This allows the board level scan path to be shortened to facilitate testing of other devices in the scan path.

#### Reserved

Do not use these instructions. They are reserved for future use.



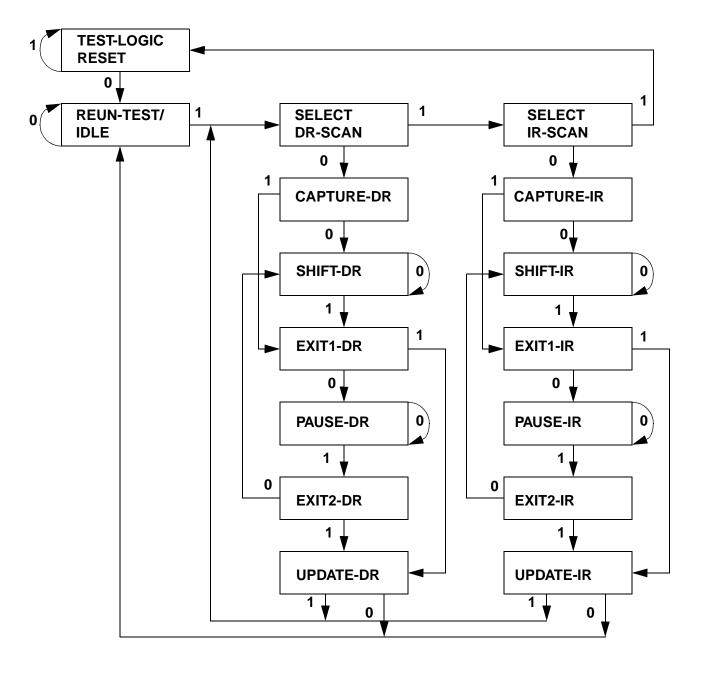


Figure 1. TAP Controller State Diagram<sup>[11]</sup>

#### Note

11. The 0/1 next to each state represents the value at TMS at the rising edge of TCK.



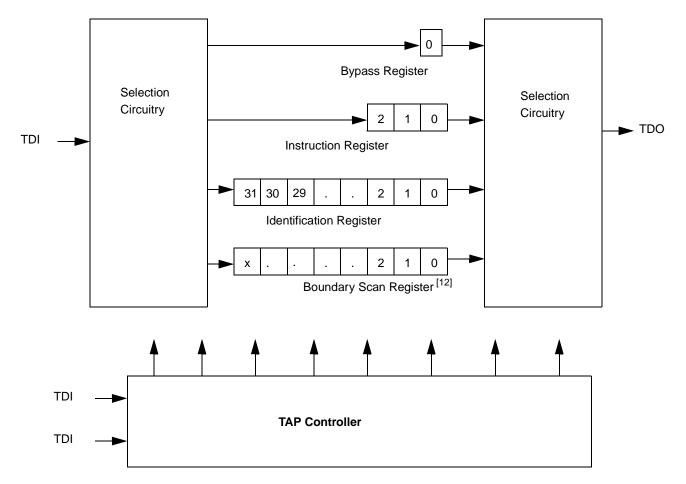


Figure 2. TAP Controller Block Diagram

# $\textbf{TAP Electrical Characteristics} \ (20^{\circ}\text{C} < \text{T}_{j} < 110^{\circ}\text{C}; \ \text{V}_{CC} = 3.3\text{V} - 0.2\text{V} \ \text{and} \ + 0.3\text{V} \ \text{unless otherwise noted})$

Parameter	Description	Test Conditions	Min.	Max.	Unit
V <sub>IH</sub>	Input High (Logic 1) Voltage <sup>[13, 14]</sup>		2.0	V <sub>CC</sub> + 0.3	V
V <sub>II</sub>	Input Low (Logic 0) Voltage <sup>[13, 14]</sup>		-0.3	0.8	V
IL <sub>I</sub>	Input Leakage Current	$0V \le V_{IN} \le VCC$	-5.0	5.0	μΑ
ILI	TMS and TDI Input Leakage Current	$0V \le V_{IN} \le VCC$	-30	30	μΑ
ILO	Output Leakage Current	Output disabled, 0V ≤ V <sub>IN</sub> ≤ V <sub>CCQ</sub>	-5.0	5.0	μА
V <sub>OLC</sub>	LVCMOS Output Low Voltage <sup>[13, 15]</sup>	I <sub>OLC</sub> = 100 μA		0.2	V
V <sub>OHC</sub>	LVCMOS Output High Voltage <sup>[13, 15]</sup>	I <sub>OHC</sub> = 100 μA	V <sub>CC</sub> - 0.2		V
V <sub>OLT</sub>	LVTTL Output Low Voltage <sup>[13]</sup>	I <sub>OLT</sub> = 8.0 mA		0.4	V
V <sub>OHT</sub>	LVTTL Output High Voltage <sup>[13]</sup>	I <sub>OHT</sub> = 8.0 mA	2.4		V

- 12. X = 69 for the x36 configuration;
- X = 69 for the X36 configuration;
   X = 50 for the X18 configuration.
   All Voltage referenced to V<sub>SS</sub> (GND).
   Overshoot: V<sub>IH</sub>(AC)≤V<sub>CC</sub>+1.5V for t≤t<sub>KHKH</sub>/2, Undershoot: V<sub>IL</sub>(AC)≤-0.5V for t≤t<sub>KHKH</sub>/2, Power-up: V<sub>IH</sub>≤3.6V and V<sub>CC</sub>≤3.135V and V<sub>CCQ</sub>≤1.4V for t≤200 ms. During normal operation, V<sub>CCQ</sub> must not exceed V<sub>CC</sub>. Control input signals (such as R/W, ADV/LD, etc.) may not have pulse widths less than t<sub>KHKL</sub> (min.).
- 15. This parameter is sampled.



# TAP AC Switching Characteristics Over the Operating Range<sup>[16, 17]</sup>

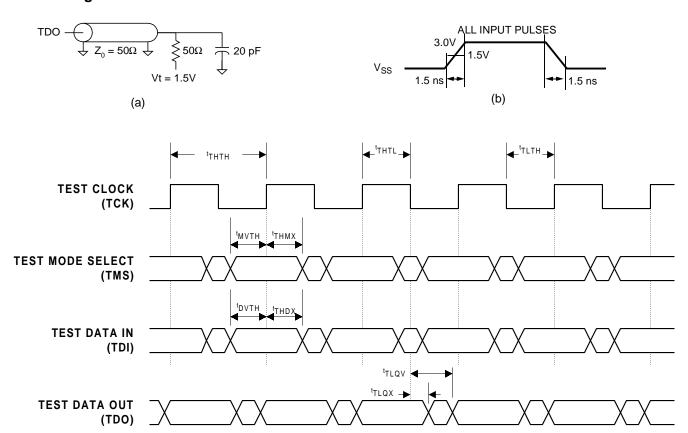
Parameter	Description	Min.	Max	Unit
Clock		•	•	•
t <sub>THTH</sub>	Clock Cycle Time	20		ns
f <sub>TF</sub>	Clock Frequency		50	MHz
t <sub>THTL</sub>	Clock HIGH Time	8		ns
t <sub>TLTH</sub>	Clock LOW Time	8		ns
Output Times	3	<u>.</u>		
t <sub>TLQX</sub>	TCK LOW to TDO Unknown	0		ns
t <sub>TLQV</sub>	TCK LOW to TDO Valid		10	ns
t <sub>DVTH</sub>	TDI Valid to TCK HIGH	5		ns
t <sub>THDX</sub>	TCK HIGH to TDI Invalid	5		ns
Set-up Times		<u>.</u>		
t <sub>MVTH</sub>	TMS Set-up	5		ns
t <sub>CS</sub>	Capture Set-up	5		ns
Hold Times		•	•	•
t <sub>THMX</sub>	TMS Hold	5		ns
t <sub>CH</sub>	Capture Hold	5		ns

#### Notes:

 <sup>16.</sup> t<sub>CS</sub> and t<sub>CH</sub> refer to the set-up and hold time requirements of latching data from the boundary scan register.
 17. Test conditions are specified using the load in TAP AC test conditions.



# **TAP Timing and Test Conditions**





# **Identification Register Definitions**

Instruction Field	256K x 36	512K x 18	Description
REVISION NUMBER (31:28)	XXXX	XXXX	Reserved for revision number.
DEVICE DEPTH (27:23)	00110	00111	Defines depth of 256K or 512K words.
DEVICE WIDTH (22:18)	00100	00011	Defines width of x36 or x18 bits.
RESERVED (17:12)	XXXXXX	XXXXXX	Reserved for future use.
CYPRESS JEDEC ID CODE (11:1)	00011100100	00011100100	Allows unique identification of DEVICE vendor.
ID Register Presence Indicator (0)	1	1	Indicates the presence of an ID register.

# **Scan Register Sizes**

Register Name	Bit Size (x36)	Bit Size (x18)
Instruction	3	3
Bypass	1	1
ID	32	32
Boundary Scan	70	51

# **Instruction Codes**

Instruction	Code	Description
EXTEST	000	Captures I/O ring contents. Places the boundary scan register between TDI and TDO. Forces all device outputs to High-Z state. This instruction is not IEEE 1149.1-compliant.
IDCODE	001	Preloads ID register with vendor ID code and places it between TDI and TDO. This instruction does not affect device operations.
SAMPLE-Z	010	Captures I/O ring contents. Places the boundary scan register between TDI and TDO. Forces all device outputs to High-Z state.
RESERVED	011	Do not use these instructions; they are reserved for future use.
SAMPLE/PRELOAD	100	Captures I/O ring contents. Places the boundary scan register between TDI and TDO. This instruction does not affect device operations. This instruction does not implement IEEE 1149.1 PRELOAD function and is therefore not 1149.1-compliant.
RESERVED	101	Do not use these instructions; they are reserved for future use.
RESERVED	110	Do not use these instructions; they are reserved for future use.
BYPASS	111	Places the bypass register between TDI and TDO. This instruction does not affect device operations.



# Boundary Scan Order (256K x 36)

Bit#         Signal Name         TQFP         Bump ID           1         A         44         2R           2         A         45         3T           3         A         46         4T           4         A         47         5T           5         A         48         6R           6         A         49         3B           7         A         50         5B           8         DQa         51         6P           9         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         73         7E           21         DQb				1
2       A       45       3T         3       A       46       4T         4       A       47       5T         5       A       48       6R         6       A       49       3B         7       A       50       5B         8       DQa       51       6P         9       DQa       52       7N         10       DQa       53       6M         11       DQa       56       7L         12       DQa       57       6K         13       DQa       58       7P         14       DQa       59       6N         15       DQa       62       6L         16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24	Bit#	Signal Name	TQFP	Bump ID
3       A       46       4T         4       A       47       5T         5       A       48       6R         6       A       49       3B         7       A       50       5B         8       DQa       51       6P         9       DQa       52       7N         10       DQa       53       6M         11       DQa       56       7L         12       DQa       57       6K         13       DQa       58       7P         14       DQa       59       6N         15       DQa       62       6L         16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26	1	А	44	2R
4         A         47         5T           5         A         48         6R           6         A         49         3B           7         A         50         5B           8         DQa         51         6P           9         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         <	2	А	45	3T
5         A         48         6R           6         A         49         3B           7         A         50         5B           8         DQa         51         6P           9         DQa         52         7N           10         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb	3	А	46	4T
6         A         49         3B           7         A         50         5B           8         DQa         51         6P           9         DQa         52         7N           10         DQa         52         7N           10         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb	4	А	47	5T
7         A         50         5B           8         DQa         51         6P           9         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A	5	А	48	6R
8         DQa         51         6P           9         DQa         52         7N           10         DQa         53         6M           11         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           29         ADV	6	А	49	3B
9 DQa 52 7N  10 DQa 53 6M  11 DQa 56 7L  12 DQa 57 6K  13 DQa 58 7P  14 DQa 59 6N  15 DQa 62 6L  16 DQa 63 7K  17 ZZ 64 7T  18 DQb 68 6H  19 DQb 69 7G  20 DQb 72 6F  21 DQb 73 7E  22 DQb 74 6D  23 DQb 75 7H  24 DQb 78 6G  25 DQb 79 6E  26 DQb 79 6E  26 DQb 80 7D  27 A 81 6A  28 A 82 5A  29 ADV 83 4G  30 ADSP 84 4A  31 ADSC 85 4B	7	А	50	5B
10         DQa         53         6M           11         DQa         56         7L           12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           28         A         82         5A           29         ADV         83         4G           30         ADSP <td>8</td> <td>DQa</td> <td>51</td> <td>6P</td>	8	DQa	51	6P
11       DQa       56       7L         12       DQa       57       6K         13       DQa       58       7P         14       DQa       59       6N         15       DQa       62       6L         16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B </td <td>9</td> <td>DQa</td> <td>52</td> <td>7N</td>	9	DQa	52	7N
12         DQa         57         6K           13         DQa         58         7P           14         DQa         59         6N           15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           28         A         82         5A           29         ADV         83         4G           30         ADSP         84         4A           31         ADSC <td>10</td> <td>DQa</td> <td>53</td> <td>6M</td>	10	DQa	53	6M
13       DQa       58       7P         14       DQa       59       6N         15       DQa       62       6L         16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B	11	DQa	56	7L
14       DQa       59       6N         15       DQa       62       6L         16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B	12	DQa	57	6K
15         DQa         62         6L           16         DQa         63         7K           17         ZZ         64         7T           18         DQb         68         6H           19         DQb         69         7G           20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           28         A         82         5A           29         ADV         83         4G           30         ADSP         84         4A           31         ADSC         85         4B	13	DQa	58	7P
16       DQa       63       7K         17       ZZ       64       7T         18       DQb       68       6H         19       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B	14	DQa	59	6N
17     ZZ     64     7T       18     DQb     68     6H       19     DQb     69     7G       20     DQb     72     6F       21     DQb     73     7E       22     DQb     74     6D       23     DQb     75     7H       24     DQb     78     6G       25     DQb     79     6E       26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	15	DQa	62	6L
18       DQb       68       6H         19       DQb       69       7G         20       DQb       72       6F         21       DQb       73       7E         22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B	16	DQa	63	7K
19     DQb     69     7G       20     DQb     72     6F       21     DQb     73     7E       22     DQb     74     6D       23     DQb     75     7H       24     DQb     78     6G       25     DQb     79     6E       26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	17	ZZ	64	7T
20         DQb         72         6F           21         DQb         73         7E           22         DQb         74         6D           23         DQb         75         7H           24         DQb         78         6G           25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           28         A         82         5A           29         ADV         83         4G           30         ADSP         84         4A           31         ADSC         85         4B	18	DQb	68	6H
21     DQb     73     7E       22     DQb     74     6D       23     DQb     75     7H       24     DQb     78     6G       25     DQb     79     6E       26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	19	DQb	69	7G
22       DQb       74       6D         23       DQb       75       7H         24       DQb       78       6G         25       DQb       79       6E         26       DQb       80       7D         27       A       81       6A         28       A       82       5A         29       ADV       83       4G         30       ADSP       84       4A         31       ADSC       85       4B	20	DQb	72	6F
23     DQb     75     7H       24     DQb     78     6G       25     DQb     79     6E       26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	21	DQb	73	7E
24     DQb     78     6G       25     DQb     79     6E       26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	22	DQb	74	6D
25         DQb         79         6E           26         DQb         80         7D           27         A         81         6A           28         A         82         5A           29         ADV         83         4G           30         ADSP         84         4A           31         ADSC         85         4B	23	DQb	75	7H
26     DQb     80     7D       27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	24	DQb	78	6G
27     A     81     6A       28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	25	DQb	79	6E
28     A     82     5A       29     ADV     83     4G       30     ADSP     84     4A       31     ADSC     85     4B	26	DQb	80	7D
29     \$\overline{ADV}\$     83     4G       30     \$\overline{ADSP}\$     84     4A       31     \$\overline{ADSC}\$     85     4B	27	А	81	6A
30         ADSP         84         4A           31         ADSC         85         4B	28	А	82	5A
31 ADSC 85 4B	29	ADV	83	4G
	30	ADSP	84	4A
32 <u>OE</u> 86 4F	31	ADSC	85	4B
	32	ŌĒ	86	4F
33 <u>BWE</u> 87 4M	33	BWE	87	4M
34 <u>GW</u> 88 4H	34	GW	88	4H
35 CLK 89 4K	35	CLK	89	4K

# Boundary Scan Order (256K x 36) (continued)

Bit#	Signal Name	TQFP	Bump ID
36	Α	92	6B
37	BWa	93	5L
38	BWb	94	5G
39	BWc	95	3G
40	BWd	96	3L
41	CE <sub>2</sub>	97	2B
42	CE	98	4E
43	Α	99	3A
44	Α	100	2A
45	DQc	1	2D
46	DQc	2	1E
47	DQc	3	2F
48	DQc	6	1G
49	DQc	7	2H
50	DQc	8	1D
51	DQc	9	2E
52	DQc	12	2G
53	DQc	13	1H
54	NC	14	5R
55	DQd	18	2K
56	DQd	19	1L
57	DQd	22	2M
58	DQd	23	1N
59	DQd	24	2P
60	DQd	25	1K
61	DQd	28	2L
62	DQd	29	2N
63	DQd	30	1P
64	MODE	31	3R
65	Α	32	2C
66	Α	33	3C
67	Α	34	5C
68	Α	35	6C
69	A1	36	4N
70	A0	37	4P



# **Boundary Scan Order (512K x 18)**

	Signal		
Bit#	Signal Name	TQFP	Bump ID
1	Α	44	2R
2	Α	45	2T
3	Α	46	3T
4	А	47	5T
5	А	48	6R
6	А	49	3B
7	А	50	5B
8	DQa	58	7P
9	DQa	59	6N
10	DQa	62	6L
11	DQa	63	7K
12	ZZ	64	7T
13	DQa	68	6H
14	DQa	69	7G
15	DQa	72	6F
16	DQa	73	7E
17	DQa	74	6D
18	А	80	6T
19	А	81	6A
20	А	82	5A
21	ADV	83	4G
22	ADSP	84	4A
23	ADSC	85	4B
24	ŌĒ	86	4F
25	BWE	87	4M
26	GW	88	4H

# Boundary Scan Order (512K x 18) (continued)

Bit#	Signal Name	TQFP	Bump ID
27	CLK	89	4K
28	Α	92	6B
29	BWa	93	5L
30	BWb	94	3G
31	CE <sub>2</sub>	97	2B
32	CE	98	4E
33	Α	99	3A
34	Α	100	2A
35	DQb	8	1D
36	DQb	9	2E
37	DQb	12	2G
38	DQb	13	1H
39	NC	14	5R
40	DQb	18	2K
41	DQb	19	1L
42	DQb	22	2M
43	DQb	23	1N
44	DQb	24	2P
45	MODE	31	3R
46	Α	32	2C
47	Α	33	3C
48	Α	34	5C
49	Α	35	6C
50	A1	36	4N
51	A0	37	4P

# **PRELIMINARY**

# CY7C1360A/GVT71256D36 CY7C1362A/GVT71512D18

### **Maximum Ratings**

(Above which the useful life may be impaired. For user guidelines, not tested.) Voltage on  $V_{CC}$  Supply Relative to  $V_{SS}$  ...... -0.5V to +4.6V V<sub>IN</sub> .....-0.5V to V<sub>CC</sub>+0.5V Storage Temperature (plastic) .....-55°C to +150° Junction Temperature .....+150°

Power Dissipation1	.0W
Short Circuit Output Current50	mΑ

## **Operating Range**

Range	Ambient Temperature <sup>[18]</sup>	V <sub>CC</sub>
Com'l	0°C to +70°C	3.3V -5% / +10%

### **Electrical Characteristics** Over the Operating Range

Parameter	Description	Test Conditions	Min.	Max.	Unit
V <sub>IHD</sub>	Input High (Logic 1) Voltage <sup>[13, 19]</sup>	Data Inputs (DQx)	2.0	V <sub>CC</sub> +0.3	V
V <sub>IH</sub>		All Other Inputs	2.0	4.6	V
V <sub>II</sub>	Input Low (Logic 0) Voltage <sup>[13, 19]</sup>		-0.5	0.8	V
IL <sub>I</sub>	Input Leakage Current	$0V \le V_{IN} \le V_{CC}$	-5	5	μΑ
IL <sub>I</sub>	MODE and ZZ Input Leakage Current <sup>[20]</sup>	$0V \le V_{IN} \le V_{CC}$	-30	30	μΑ
ILo	Output Leakage Current	Output(s) disabled, 0V ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub>	-5	5	μА
V <sub>OH</sub>	Output High Voltage <sup>[13]</sup>	$I_{OH} = -5.0 \text{ mA}$	2.4		V
V <sub>OL</sub>	Output Low Voltage <sup>[13]</sup>	I <sub>OL</sub> = 8.0 mA		0.4	V
V <sub>CC</sub>	Supply Voltage <sup>[13]</sup>		3.135	3.6	V
V <sub>CCQ</sub>	I/O Supply Voltage (3.3V) <sup>[13]</sup>		3.135	V <sub>CC</sub>	V
V <sub>CCQ</sub>	I/O Supply Voltage (2.5V) <sup>[13]</sup>		2.375	V <sub>CC</sub>	V

Parameter	Description	Conditions	Тур.	-4.4	-5	-6	-6.7	Unit
I <sub>CC</sub>	Power Supply Current: Operating <sup>[21, 22, 23]</sup>	Device selected; all inputs $\leq$ V <sub>IL</sub> or $\geq$ V <sub>IH</sub> ; cycle time $\geq$ t <sub>KC</sub> min.; V <sub>CC</sub> = Max.; outputs open	150	570	510	425	380	mA
I <sub>SB2</sub>	CMOS Standby <sup>[22, 23]</sup>	Device deselected; $V_{CC} = Max.$ ; all inputs $\leq V_{SS} + 0.2$ or $\geq V_{CC} - 0.2$ ; all inputs static; CLK frequency = 0	5	10	10	10	10	mA
I <sub>SB3</sub>	TTL Standby <sup>[22, 23]</sup>	Device deselected; all inputs $\leq V_{IL}$ or $\geq V_{IH}$ ; all inputs static; $V_{CC} = Max. CLK frequency = 0$	15	30	30	30	30	mA
I <sub>SB4</sub>	Clock Running <sup>[22, 23]</sup>	Device deselected; all inputs $\leq$ V <sub>IL</sub> or $\geq$ V <sub>IH</sub> ; V <sub>CC</sub> = Max.; CLK cycle time $\geq$ t <sub>KC</sub> Min.	40	125	110	90	80	mA

# Capacitance<sup>[15]</sup>

Parameter	Description	Test Conditions	Тур.	Max.	Unit
C <sub>I</sub>	Input Capacitance	$T_A = 25^{\circ}C, f = 1 \text{ MHz},$	5	7	pF
C <sub>O</sub>	Input/Output Capacitance (DQ)	$V_{CC} = 3.3V$	7	8	pF

#### Notes:

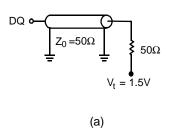
- 18.  $T_{\Delta}$  is the case temperature.
- Overshoot: V<sub>IH</sub> ≤ +6.0V for t ≤ t<sub>KC</sub> /2
   Undershoot: V<sub>IL</sub> ≤ -2.0V for t ≤ t<sub>KC</sub> /2.
   Output loading is specified with C<sub>L</sub>=5 pF as in AC Test Loads.
- 21. I<sub>CC</sub> is given with no output current. I<sub>CC</sub> increases with greater output loading and faster cycle times.
- 22. "Device Deselected" means the device is in Power-Down mode as defined in the truth table. "Device Selected" means the device is active. 23. Typical values are measured at 3.3V, 25°C, and 20 ns cycle time.

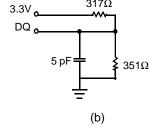


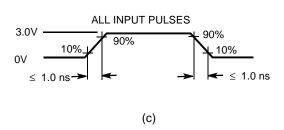
### **Thermal Resistance**

Description	Test Conditions	Symbol	TQFP Typ.	Units
Thermal Resistance (Junction to Ambient)	Still Air, soldered on a 4.25 x 1.125 inch, 4-layer PCB	$\Theta_{JA}$	25	°C/W
Thermal Resistance (Junction to Case)	4-layer FCD	$\Theta^{\sf JC}$	9	°C/W

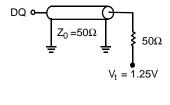
### AC Test Loads and Waveforms for 3.3V I/O



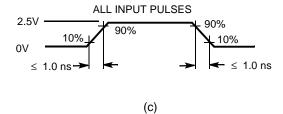




### AC Test Loads and Waveforms for 2.5V I/O



(a)





# Switching Characteristics Over the Operating Range<sup>[24]</sup>

	Description		-4.4 225 MHz		-5 200 MHz		-6 166 MHz		-6.7 150 MHz		
Parameter			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Unit
Clock			ı			u e					I
t <sub>KC</sub>	Clock Cycle Time		4.4		5.0		6.0		6.7		ns
t <sub>KH</sub>	Clock HIGH Time		1.7		2.0		2.4		2.6		ns
t <sub>KL</sub>	Clock LOW Time		1.7		2.0		2.4		2.6		ns
Output Tim	es			•		•					
t <sub>KQ</sub>	Clock to Output Valid	$V_{CCQ} = 3.3V$		2.5		3.0		3.5		3.5	ns
		$V_{CCQ} = 2.5V$		3.0		3.5		4.0		4.5	
t <sub>KQX</sub>	Clock to Output Invalid		1.25		1.25		1.25		1.25		ns
t <sub>KQLZ</sub>	Clock to Output in Low-Z <sup>[15, 25, 26]</sup>		0		0		0		0		ns
t <sub>KQHZ</sub>	Clock to Output in High-Z <sup>[15, 25, 26]</sup>		1.25	3.0	1.25	3.0	1.25	4.0	1.25	4.0	ns
t <sub>OEQ</sub>	OE to Output Valid <sup>[27]</sup>	$V_{CCQ} = 3.3V$		2.5		3.0		3.5		3.5	ns
		$V_{CCQ} = 2.5V$		3.0		3.5		4.0		4.5	
t <sub>OELZ</sub>	OE to Output in Low-Z <sup>[15, 25, 26]</sup>		0		0		0		0		ns
t <sub>OEHZ</sub>	OE to Output in High-Z <sup>[15, 25, 26]</sup>			2.5		2.5		3.5		3.5	ns
Set-up Tim	es										I
t <sub>S</sub>	Address, Controls, and Data In[28]		1.5		1.5		1.5		2.0		ns
Hold Times							ı			ı	ı
t <sub>H</sub>	Address, Controls, and Data In[28]		0.5		0.5		0.5		0.5		ns

# **Typical Output Buffer Characteristics**

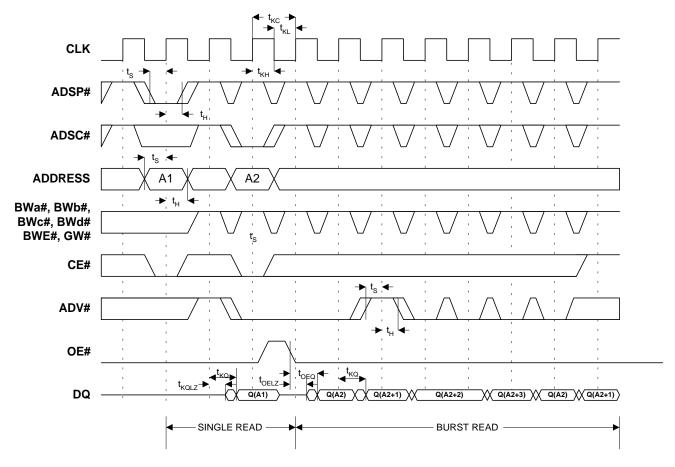
Output High Voltage	Pull-Up Current		Output Low Voltage	Pull-Dow	n Current
V <sub>OH</sub> (V)	I <sub>OH</sub> (mA) Min.	I <sub>OH</sub> (mA) Max.	V <sub>OL</sub> (V)	I <sub>OL</sub> (mA) Min.	I <sub>OL</sub> (mA) Max.
-0.5	-38	-105	-0.5	0	0
0	-38	-105	0	0	0
0.8	-38	-105	0.4	10	20
1.25	-26	-83	0.8	20	40
1.5	-20	<b>-7</b> 0	1.25	31	63
2.3	0	-30	1.6	40	80
2.7	0	-10	2.8	40	80
2.9	0	0	3.2	40	80
3.4	0	0	3.4	40	80

- Zest conditions as specified with the output loading as shown in part (a) of AC Test Loads unless otherwise noted.
  Output loading is specified with C<sub>L</sub>=5 pF as in part (a) of AC Test Loads.
  At any given temperature and voltage condition, t<sub>KOHZ</sub> is less than t<sub>KOLZ</sub> and t<sub>OEHZ</sub> is less than t<sub>OELZ</sub>.
  OE is a "Don't Care" when a byte write enable is sampled LOW.
  This is a synchronous device. All synchronous inputs must meet specified set up and hold time, except for "Don't Care" as defined in the truth table.



### **Switching Waveforms**

Read Timing<sup>[29, 30]</sup>



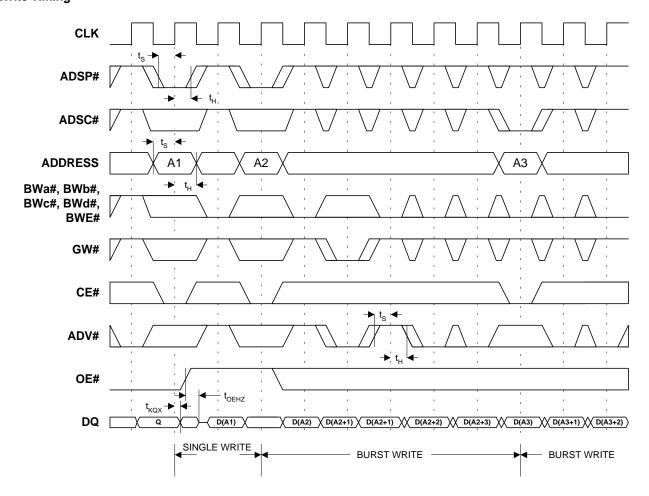
### Notes:

- 29.  $\overline{\text{CE}}$  active in this timing diagram means that all chip enables  $\overline{\text{CE}}$ ,  $\text{CE}_2$ , and  $\overline{\text{CE}}_2$  are active.  $\overline{\text{CE}}_2$  is only available for TA package version. 30. For the X18 product, there are only  $\overline{\text{BWa}}$  and  $\overline{\text{BWb}}$  for byte write control.



# Switching Waveforms (continued)

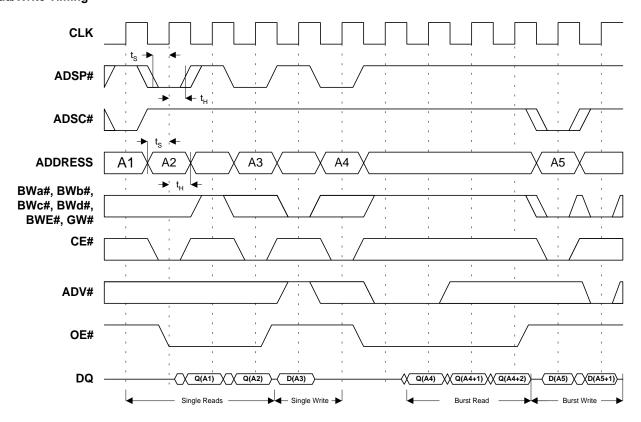
Write Timing<sup>[29, 30]</sup>





# Switching Waveforms (continued)

Read/Write Timing<sup>[29, 30]</sup>





# **Ordering Information**

Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range	
225 CY7C1360A-225AJC/ GVT71256D36T-4.4		A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack	Commercial	
	CY7C1360A-225AC/ GVT71256D36TA-4.4	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-225BGC/ GVT71256D36B-4.4	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
200	CY7C1360A-200AJC/ GVT71256D36T-5	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-200AC/ GVT71256D36TA-5	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-200BGC/ GVT71256D36B-5	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
166	CY7C1360A-166AJC/ GVT71256D36T-6	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-166AC/ GVT71256D36TA-6	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-166BGC/ GVT71256D36B-6	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
150	CY7C1360A-150AJC/ GVT71256D36T-6.7	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-150AC/ GVT71256D36TA-6.7	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1360A-150BGC/ GVT71256D36B-6.7	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		



# Ordering Information (continued)

Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range	
225 CY7C1362A-225AJC/ GVT71512D18T-4.4		A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack	Commercial	
	CY7C1362A-225AC/ GVT71512D18TA-4.4	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-225BGC/ GVT71512D18B-4.4	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
200	200 CY7C1362A-200AJC/ GVT71512D18T-5		100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-200AC/ GVT71512D18TA-5	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-200BGC/ GVT71512D18B-5	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
166	CY7C1362A-166AJC/ GVT71512D18T-6	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-166AC/ GVT71512D18TA-6	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-166BGC/ GVT71512D18B-6	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		
150	CY7C1362A-150AJC/ GVT71512D18T-6.7	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-150AC/ GVT71512D18TA-6.7	A101	100-Lead 14 x 20 x 1.4 mm Thin Quad Flat Pack		
	CY7C1362A-150BGC/ GVT71512D18B-6.7	BG119	119-Lead FBGA (14 x 22 x 2.4 mm)		

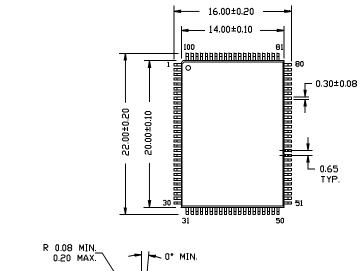
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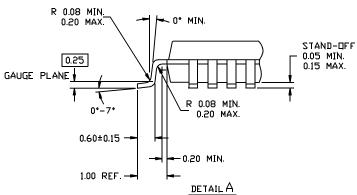


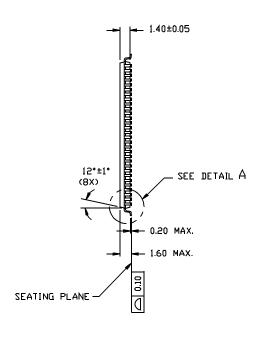
### **Package Diagrams**

### 100-Pin Thin Plastic Quad Flatpack (14 x 20 x 1.4 mm) A101

DIMENSIONS ARE IN MILLIMETERS.







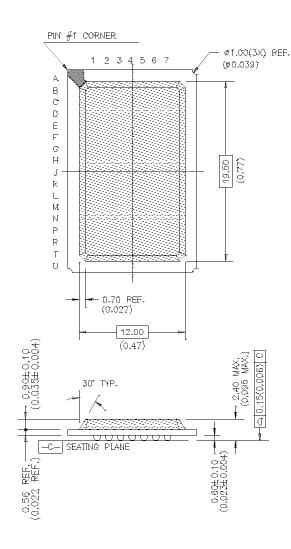
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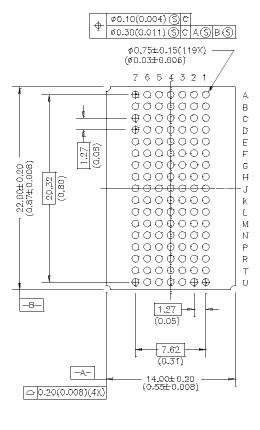


### Package Diagrams (continued)

### 119-Lead FBGA (14 x 22 x 2.4 mm) BG119

DIMENSION IN MILLIMETERS (INCHES)





51-85115

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